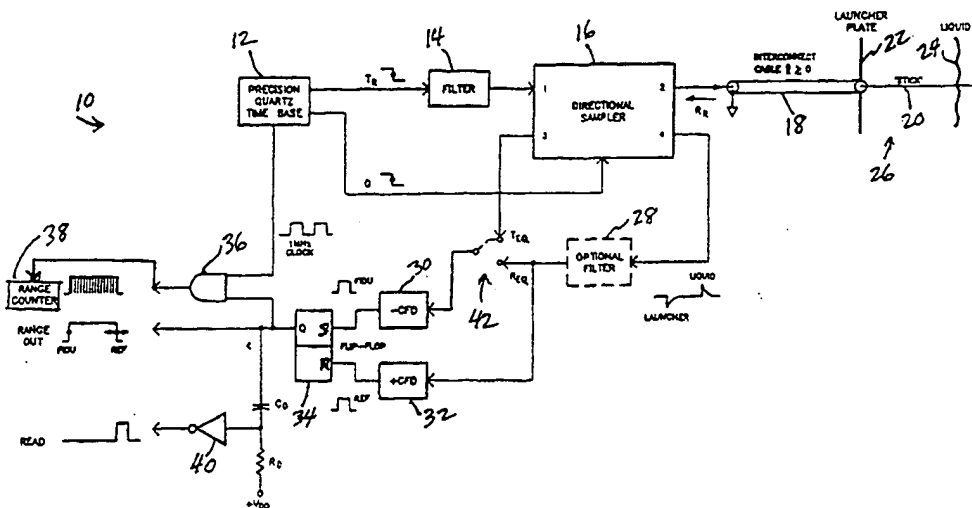




INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(51) International Patent Classification n ^o : G01S 13/00, G01F 23/28	A1	(11) International Publication Number: WO 97/06448 (43) International Publication Date: 20 February 1997 (20.02.97)
(21) International Application Number: PCT/US96/12499 (22) International Filing Date: 30 July 1996 (30.07.96) (30) Priority Data: 08/510,980 3 August 1995 (03.08.95) US (71) Applicant: THE REGENTS OF THE UNIVERSITY OF CALIFORNIA [US/US]; 22nd floor, 300 Lakeside Drive, Oakland, CA 94612 (US). (72) Inventor: McEWAN, Thomas, E.; 1734 Cairo Street, Livermore, CA 94550 (US). (74) Agent: SARTORIO, Henry, P.; P.O. Box 808, L-703, Livermore, CA 94550 (US).	(81) Designated States: AL, AM, AT, AU, AZ, BB, BG, BR, BY, CA, CH, CN, CZ, DE, DK, EE, ES, FI, GB, GE, HU, IL, IS, JP, KE, KG, KP, KR, KZ, LK, LR, LS, LT, LU, LV, MD, MG, MK, MN, MW, MX, NO, NZ, PL, PT, RO, RU, SD, SE, SG, SI, SK, TJ, TM, TR, TT, UA, UG, UZ, VN, ARIPO patent (KE, LS, MW, SD, SZ, UG), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, CH, DE, DK, ES, FI, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, ML, MR, NE, SN, TD, TG). Published With international search report.	

(54) Title: HIGH ACCURACY ELECTRONIC MATERIAL LEVEL SENSOR



(57) Abstract

The High Accuracy Electronic Material Level Sensor (electronic dipstick) is a sensor based on time domain reflectometry (TDR) of very short electrical pulses. Pulses are propagated along a transmission line or guide wire (20) that is partially immersed in the material being measured; a launcher plate (22) is positioned at the beginning of the guide wire (20). Reflected pulses are produced at the material interface due to the change in dielectric constant. The time difference of the reflection at the launcher plate (22) and at the material interface (24) or the time difference of the transmit pulse and the reflection at the material interface are used to determine the material level. Improved performance is obtained by the incorporation of: 1) a high accuracy time base (12) that is referenced to a quartz crystal; 2) an ultrawideband directional sampler (16) to allow operation without an interconnect cable (18) between the electronics module and the guide wire (20); and 3) constant fraction discriminators (CFD's 30, 32) that allow accurate measurements regardless of material dielectric constants, and reduce or eliminate errors induced by triple-transit or "ghost" reflections on the interconnect cable (18).

FOR THE PURPOSES OF INFORMATION ONLY

Codes used to identify States party to the PCT on the front pages of pamphlets publishing international applications under the PCT.

AM	Armenia	GB	United Kingdom	MW	Malawi
AT	Austria	GE	Georgia	MX	Mexico
AU	Australia	GN	Guinea	NE	Niger
BB	Barbados	GR	Greece	NL	Netherlands
BE	Belgium	HU	Hungary	NO	Norway
BF	Burkina Faso	IE	Ireland	NZ	New Zealand
BG	Bulgaria	IT	Italy	PL	Poland
BJ	Benin	JP	Japan	PT	Portugal
BR	Brazil	KE	Kenya	RO	Romania
BY	Belarus	KG	Kyrgyzstan	RU	Russian Federation
CA	Canada	KP	Democratic People's Republic of Korea	SD	Sudan
CF	Central African Republic	KR	Republic of Korea	SE	Sweden
CG	Congo	KZ	Kazakhstan	SG	Singapore
CH	Switzerland	LI	Liechtenstein	SI	Slovenia
CI	Côte d'Ivoire	LK	Sri Lanka	SK	Slovakia
CM	Cameroon	LR	Liberia	SN	Senegal
CN	China	LT	Lithuania	SZ	Swaziland
CS	Czechoslovakia	LU	Luxembourg	TD	Chad
CZ	Czech Republic	LV	Latvia	TG	Togo
DE	Germany	MC	Monaco	TJ	Tajikistan
DK	Denmark	MD	Republic of Moldova	TT	Trinidad and Tobago
EE	Estonia	MG	Madagascar	UA	Ukraine
ES	Spain	ML	Mali	UG	Uganda
FI	Finland	MN	Mongolia	US	United States of America
FR	France			UZ	Uzbekistan

- 1 -

HIGH ACCURACY ELECTRONIC MATERIAL
LEVEL SENSOR

The United States Government has rights in this invention pursuant to Contract No. W-7405-ENG-48 between the United States Department of Energy and the University of California for the operation of Lawrence Livermore National Laboratory.

5

RELATED APPLICATIONS

This application is a continuation-in-part (CIP) of application Ser. No. 08/359,090 filed Dec. 19, 1994, which is herein incorporated by reference.

BACKGROUND OF THE INVENTION

10 The invention relates to material level sensors and more particularly to electronic material level sensors using time domain reflectometry (TDR).

Parent application Ser. No. 08/359,090 filed Dec. 19, 1994 describes an electronic material level sensor or "electronic dipstick" based on time domain reflectometry (TDR) of very short electrical
15 pulses. Pulses are propagated along a transmission line or guide wire that is partially immersed in the material being measured; a launcher plate is positioned at the beginning of the guide wire. Reflected pulses are produced at the material interface due to the change in dielectric constant. The time difference of the reflections at the launcher plate and
20 at the material interface are used to determine the material level. Accuracy of about 1% is achieved where the time base accuracy is dependent on RC components. In some cases, however, there is a need for more accurate measurement of material level.

25 There is also a problem when the reflected pulse returns while the outbound pulse is still being transmitted, i.e. when the reflecting discontinuity is very close to the input or launch end of the transmission line. In these cases it may be necessary to connect the electronics to the transmission line through a cable to sufficiently separate the transmitted and reflected pulses. However, there is a need

- 2 -

for a system which does not require a cable wherein the electronics can be connected directly to the launch point of the dipstick.

U.S. Patent No. 5,345,471 and copending CIP application Ser. No. 08/301,924 filed Sept. 6, 1994, which are herein incorporated by
5 reference, describe an ultra-wideband (UWB) receiver which utilizes a strobed input line with a sampler connected to an amplifier. The outputs of two integrating single-ended samplers are input into a differencing amplifier. The samplers integrate, or average, up to 10,000 pulses.

10 Copending application Ser. No. 08/510,956, filed August 3, 1995, entitled "Ultra-Wideband Directional Sampler" describes a four port electronic directional coupler which combines a directional coupler with a high speed sampler for use in time domain reflectometry. Two of the ports operate at sub-nanosecond speed, in "real time", and the other
15 two ports operate at a slower millisecond speed, in "equivalent time". A signal flowing inbound to either of the high speed ports is sampled and coupled, in equivalent time, to the adjacent equivalent time port while being isolated from the opposite equivalent time port.

Copending application Ser. No. 08/510,524, filed Aug. 2, 1995 entitled "Precision Digital Pulse Phase Generator" describes a high
20 accuracy time base that is referenced to a quartz crystal.

SUMMARY OF THE INVENTION

Accordingly it is an object of the invention to improve accuracy of electronic material level sensors.

The High Accuracy Electronic Material Level Sensor
25 (electronic dipstick) of the invention improves upon the original electronic material level sensor by the incorporation of: 1) a high accuracy time base that is referenced to a quartz crystal, 2) an ultrawideband directional sampler to allow operation without an interconnect cable between the electronics module and the guide wire,
30 3) constant fraction discriminators (CFDs) that allow accurate measurements regardless of material dielectric constants, and 4) means to reduce or eliminate errors induced by triple-transit or "ghost" reflections on the interconnect cable.

These improvements make the dipstick accurate enough,
35 e.g. better than 0.1%, to permit "custody transfer" measurements in large

- 3 -

tanks, such as supertanker holds, that can be relied upon over temperature extremes and with aging. Further, operation without an interconnect cable reduces the bulk and cost of dipstick sensors where the electronics are located in the launcher plate, such as a dipstick
5 located in the filler cap of a gas tank.

The previous dipstick works well when a cable connects the electronics to the "stick", but there is a demand for a version of the dipstick that does not need a cable and where the electronics are mounted directly at the launch point for the dipstick. This
10 configuration includes situations where the dipstick electronics are mounted on the filler cap, such as gas tanks for outboard motor boats or for automobiles.

Furthermore, a significant number of fluid level sensing applications need greater than the 1 % accuracy provided by the original
15 dipstick where the time base accuracy is dependent on RC components. The present invention provides accuracy of 0.1% or better.

BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a schematic diagram of the high accuracy material level sensor.

Fig. 2 is a circuit diagram of a constant fraction
20 discriminator.

Fig. 3A illustrates the normal reflection path to a liquid level and unwanted ghost paths; Fig. 3B is a timing diagram of the reflections.

DETAILED DESCRIPTION OF THE INVENTION

Fig. 1 depicts the general arrangement of the High Accuracy
25 Electronic Material Level Sensor, or "Dipstick" 10. A precision quartz time base 12 generates a real time transmit pulse T_R and a gate pulse G with a precision swept delay between T_R and G . Typically the delay = $T_R - G$ sweeps from 0 to 20ns, and recurs at a 2MHz rate. The time base 10 is described in copending application Ser. No. 08/510,524, filed Aug. 2, 1995
30 entitled "Precision Digital Pulse Phase Generator" which is herein incorporated by reference. T_R is applied to a filter 14, nominally a differentiator, i.e. high pass filter, to convert the leading edge of T_R into a narrow pulse. Additionally, the filter 14 provides low pass filtering to assure that no fast spikes get through for purposes to be explained below.

- 4 -

If transmit pulses T_R of suitable characteristics are produced, then filter 14 may be unnecessary; alternately, filter 14 need not be a separate component, but may be incorporated into another component, e.g. time base 12.

5 The directional sampler 16 receives the transmit pulses T_R at input port 1 and passes T_R through port 2 to the dipstick interconnect cable 18 with attached dipstick assembly 26 and to its sampled equivalent time output port 3 as T_{EQ} . Reflected pulses R_R at port 2 from the dipstick appear at the sampled equivalent time output port 4 as R_{EQ} . The
10 equivalent time outputs are typically on a millisecond time scale and provide an analog replica of the T_R and R_R pulses that occur on a sub-nanosecond scale. Directional sampler 16 is described in copending application Ser. No. 08/510,956, filed herewith entitled "Ultra-Wideband Directional Sampler" which is herein incorporated by reference.

15 There are four ports in directional sampler 16 where ports 1 and 2 are "real time" ports and ports 3 and 4 are sampled "equivalent time" ports. Ports 1 and 2 are bidirectional regarding signal flow. Ports 3 and 4 are output ports from a differential sampler within the coupler, and are not bidirectional. They are outputs only and the outputs are
20 equivalent time replicas of the real time signals at ports 1 and 2. A portion of the signal T_R exiting port 2 reflects back as a reflected signal R_R into port 2. This signal is sampled and appears in equivalent time at port 4 but not at port 3. Port 1 is the input port that couples a transmitted signal T_R to port 2. Port 2 is connected to dipstick assembly
25 26 through an optional interconnect cable 18. A gate signal G is applied to directional sampler 16 from time base 12 to operate the sampler 16.

 Port 2 of sampler 16 is connected through interconnect cable 18 to transmission line or guide wire ("stick") 20. A launcher plate 22 is mounted at the junction between lines 18 and 20. Guide wire 20
30 extends into a liquid (or other material) 24. The dipstick assembly 26 comprises the launcher plate 22 and the metallic guide wire or "stick" 20. The operation of dipstick assembly 26 is described in U.S. Patent application Ser. No. 08/359,090 which is herein incorporated by reference. Pulses are reflected from the liquid 24 into which the stick 20
35 is inserted and provide a reflected signal R_R back into port 2. An

- 5 -

equivalent time replica of R_R appears at port 4 while an equivalent time replica of T_R appears at port 3.

5 An optional filter 28 in the path of R_{EQ} performs the same function as the filter 14 in the T_R path. Since the T_R pulses arrive at the R_{EQ} path via a linear transfer, the filter may be placed in either location (14 or 28) for the same effect. However, the T_R path (filter 14) is preferred since it simplifies the electronics.

10 The T_{EQ} output from port 4 is applied to a constant fraction discriminator (-CFD) 30 that threshold detects at a constant fraction of the maximum amplitude of the T_{EQ} pulse regardless of its amplitude. Similarly, a constant fraction discriminator (+CFD) 32 in the R_{EQ} path performs the same stabilizing function on the R_{EQ} pulse. The two CFDs 30, 32 are of opposite sign because of the different polarity of the transmitted and reflected pulses.

15 Since the R_{EQ} pulse amplitude scales with the dielectric constant of the liquid, the +CFD 32 provides a consistent thresholding action regardless of pulse amplitude and makes the accuracy of the dipstick independent of the liquid dielectric constant.

20 The combination of the two CFDs 30, 32 make the system independent of the amplitude of the transmit pulse T_R and its risetime. Although the amplitude of the T_R pulse is scaled by a stable, regulated power supply, its risetime may vary over temperature or with production spreads since risetime is a function of process-dependent variables such as the transition frequency or gain bandwidth of a transistor. Once the risetime of T_R passes through a differentiator, e.g. filter 14, the resulting pulse amplitude is risetime dependent.

25 The outputs of the CFDs 30, 32 are applied to a set-reset flip-flop 34 that provides a variable pulse width output proportional to the time delay between the launcher plate reflection and the liquid level. A jumper option at the -CFD 30 input allows the -CFD 30 to trigger, or provide a fiducial pulse FIDU occurring at the transmit time T_{EQ} or at the launcher plate reflection time appearing as a negative R_{EQ} pulse. By means of switch 42, e.g. a manual toggle switch, the user can connect either port 3 (T_{EQ}) or port 4 (R_{EQ}) to the input of -CFD 30. Port 4 is
30 always connected to +CFD 32. When T_{EQ} is connected to -CFD 30, the measurement is between the transmit pulse and the liquid level; the
35

- 6 -

two signals are of opposite polarity. When R_{EQ} is connected to both CFDs 30, 32, -CFD 30 sees the negative pulse reflected from the launcher plate 22 while +CFD 32 sees the positive pulse reflected from the liquid 24. Thus the liquid level measurement can be referenced from the
5 launcher plate or from the transmit pulse.

Since the flip-flop 34 is set by the FIDU signal from -CFD 30 and reset by the liquid reflection signal REF from +CFD 32, it provides a differential interval measurement, whereby zero offset drift in the time base is subtracted out. In the case where the FIDU is the launcher plate
10 reflection, the interconnect cable delay is additionally subtracted out.

The output of the flip-flop 34 further gates through AND gate 36 a clock pulse from time base 12, typically at a 1 MHz frequency, to provide a burst to a range counter 38. Counter 38 counts from the FIDU signal from the -CFD 30 until the REF signal from +CFD 32 to provide
15 the range or material level measurement. Each pulse in this burst corresponds typically to 0.001" in FIDU to REF time difference, or liquid level range. The negative transition from the flip-flop 34 labeled REF is differentiated by C_D , R_D to provide a READ command at the output of inverter 40. The time base repeats its sweep at a nominal 40 Hz rate, and
20 thus the RANGE OUT signal repeats at 40 Hz to provide range data every 25ms.

Figure 2 shows a simple CFD 50. A comparator C receives a pulse at its positive input with a maximum amplitude V_{MAX} . The pulse input is also applied through a resistive divider R_1 , R_2 to a peak detector
25 52. The peak detector 52 is comprised of an operational amplifier A, a detector diode D, a charge holding capacitor C_H and slow discharge resistor R_H , and a low-value stabilizing resistor R_S . The output of the peak detector 52 is a steady DC level corresponding to the peak V_{MAX} and scaled down by a constant fraction set by R_1 , R_2 , e.g. $V_{MAX}/2$. Naturally,
30 the input must be repetitive for the peak detector 52 to acquiesce to a steady value. This scaled DC level is the threshold reference for C at its negative input. If the V_{MAX} of the pulse changes, so does the DC reference applied to the reference or minus input of C, in exact proportion. Thus the trigger point stays at the same relative fraction of
35 the input pulse regardless of its amplitude.

- 7 -

Fig 3A shows the normal reflection path L1, L2 to a liquid 24 level and back to the electronics 60. Fig. 3A also shows an unwanted ghost path caused by multiple reflections L3, L4, L5, L6 to the launcher plate 22 and back to the electronics 60. These reflections cause a small ghost pulse that can sum with the reflected pulse and cause measurement errors when the ghost pulse lines up with the reflected pulse. Fig. 3B shows a timing diagram for the various reflections. However, the use of the +CFD reduces this error since the summation of the ghost pulse with the reflection pulse changes the amplitude of the net pulse. This amplitude change is compensated by the CFD, and thus there is little or no net error. The ghost pulse may be positive or negative depending on exact impedance mismatches between the electronics 60 and the cable 18.

For the +CFD to accurately compensate ghost and reflected pulse summation, the pulses should not have fast spikes or long-term aberrations. Hence the filter 14 in the T_R path is used.

The use of the directional sampler 16 eliminates the need for the interconnect cable 18. Thus the electronics package 60 can be connected directly to the guide wire 20 so there will be no reflection from the launcher plate 22.

Changes and modifications in the specifically described embodiments can be carried out without departing from the scope of the invention which is intended to be limited only by the scope of the appended claims.

- 8 -

THE INVENTION CLAIMED IS

1. Apparatus for measuring the level of a material, comprising:

a precision time base for generating a real time transmit pulse and a gate pulse;

5 a directional sampler having a first port for receiving the real time transmit pulse, a second port coupled to the first port for transmitting the real time transmit pulse, a third port coupled to the first port and isolated from the second port, and a fourth port coupled to the second port, the directional sampler being gated by the gate pulse;

10 a dipstick assembly connected to the second port;

first and second constant fraction discriminators (CFDs) of opposite polarity, the first CFD switchingly connected to the third and fourth ports, the second CFD connected to the fourth port

a set-reset flip-flop connected to the first and second CFDs.

2. The apparatus of Claim 1 wherein the precision time delay generates a precision swept delay between the real time transmit pulse and the gate pulse.

3. The apparatus of Claim 1 further comprising a high pass filter between the time base and the first port.

4. The apparatus of Claim 3 wherein the filter is also a low pass filter to remove fast spikes from the transmit pulse.

5. The apparatus of Claim 1 wherein the third and fourth ports of the directional sampler are equivalent time ports.

6. The apparatus of Claim 1 wherein the dipstick assembly comprises a guide wire for partial immersion in the material, and a launcher plate at the beginning of the guide wire.

7. The apparatus of Claim 6 further comprising an interconnect cable between the second port and the dipstick assembly.

8. The apparatus of Claim 6 further comprising a switch between the first CFD and the third and fourth output ports.

9. The apparatus of Claim 8 wherein the switch connects the third port to the first CFD for referencing the material level to the transmit pulse.

- 9 -

10. The apparatus of Claim 8 wherein the switch connects the fourth port to the first CFD for referencing the material level to the launcher plate.

11. The apparatus of Claim 1 further comprising a range counter connected to the output of the flip-flop.

12. The apparatus of Claim 11 further comprising an AND gate connected between the flip-flop and range counter, the AND gate receiving a clock signal from the time base.

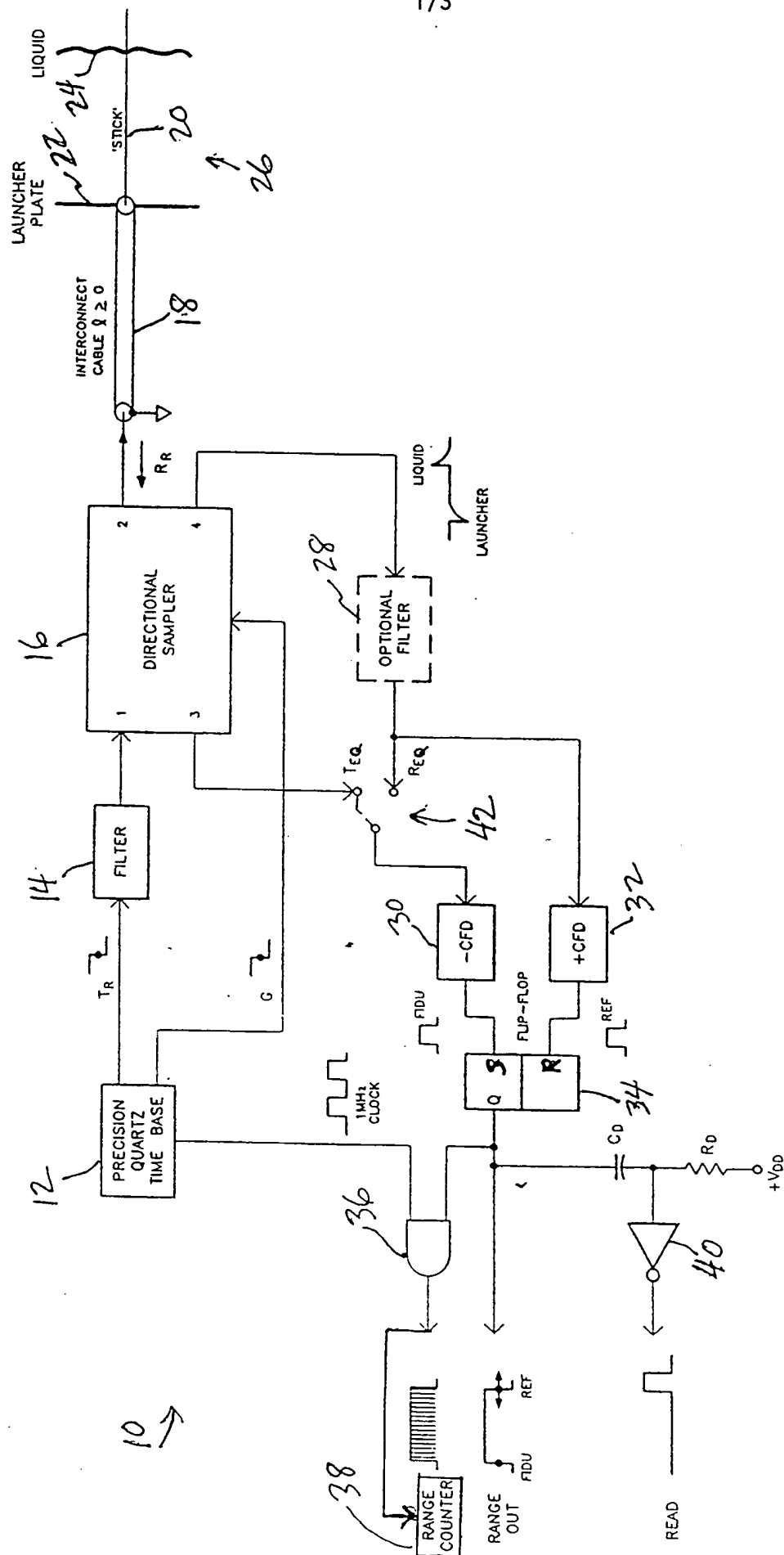


FIG. 1

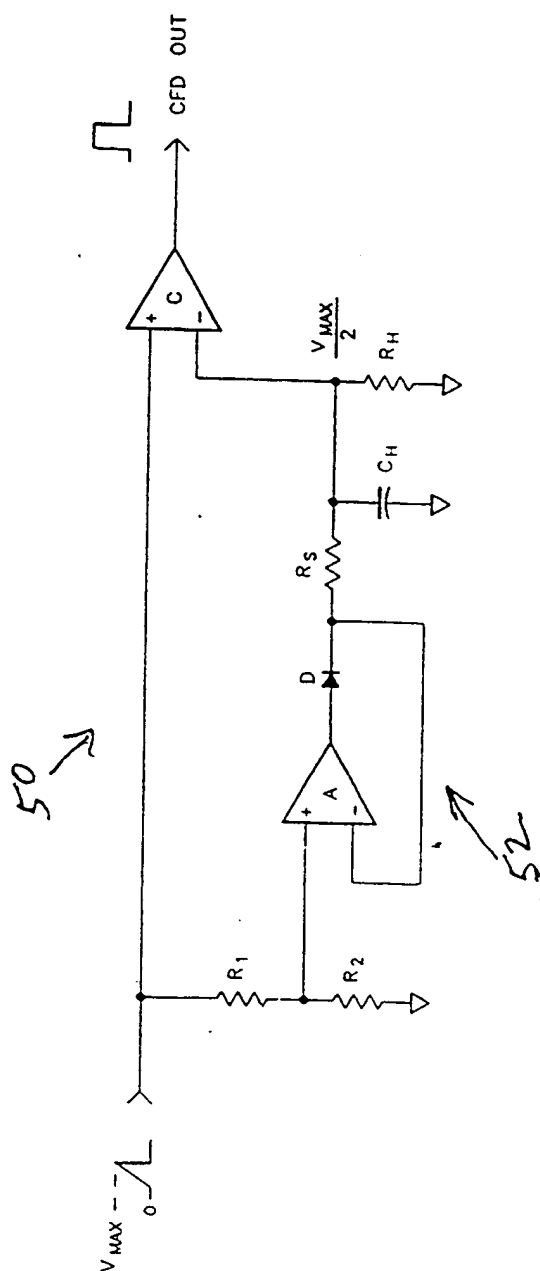


FIGURE 2. CONSTANT FRACTION DISCRIMINATOR

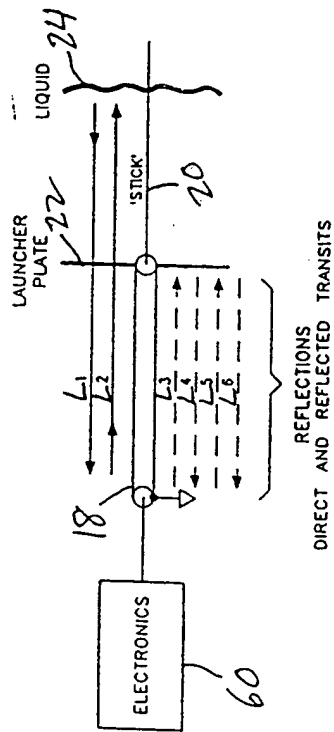


FIGURE 3A. - GHOST PULSE MECHANISM

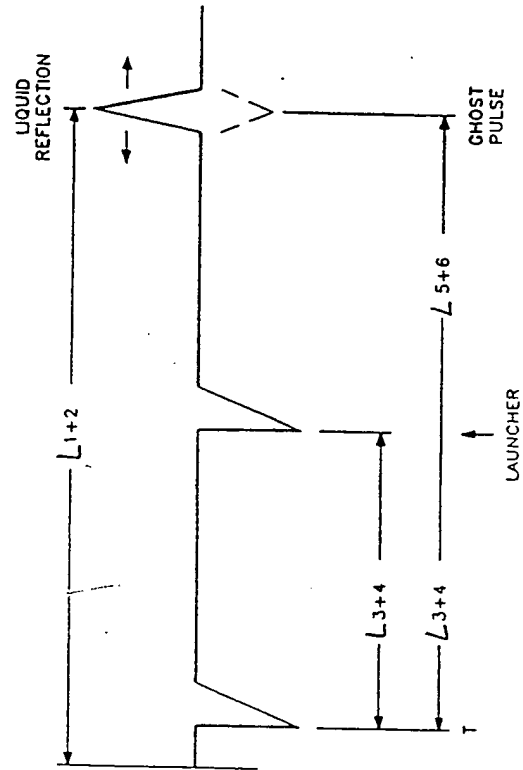


FIGURE 3B. TIMING DIAGRAM

INTERNATIONAL SEARCH REPORT

International application No.
PCT/US96/12499

A. CLASSIFICATION OF SUBJECT MATTER

IPC(6) : G01S 13/00; G01F 23/28

US CL : 342/089, 124; 073/290.R, 290.V

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

U.S. : 342/089, 124; 073/290.R, 290.V; 324/644

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

APS: DIFFERENTIAL (3A) SAMPL, TIME DOMAIN REFLECTOMETRY, CONSTANT FRACTION DISCRIMINATOR, (LIQUID OR MATERIAL) (W) LEVEL, LAUNCHER PLATE, 073/CLAS

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	US 2,709,918 A (YETTER) 07 June 1955, see entire document.	1-12
A	US 3,394,589 A (GENICHIRO TOMIOKA) 30 July 1968 see the entire document.	1-12
A	US 3,832,900 A (ROSS) 03 September 1974, see the entire document.	1-12
A	US 3,995,212 A (ROSS) 30 November 1976, see the entire document.	1-12
A	US 4,135,397 A (KRAKE) 23 January 1979, see the entire document.	1-12
A	US 4,153,366 A (MAMON ET AL.) 08 May 1979, see the entire document.	1-12

☒ Further documents are listed in the continuation of Box C. ☐ See patent family annex.

* Special categories of cited documents:	*T	later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
A document defining the general state of the art which is not considered to be of particular relevance	*X*	document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
E earlier document published on or after the international filing date	*Y*	document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
L document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)	*Z*	document member of the same patent family
O document referring to an oral disclosure, use, exhibition or other means		
P document published prior to the international filing date but later than the priority date claimed		

Date of the actual completion of the international search

23 OCTOBER 1996

Date of mailing of the international search report

07 NOV 1996

Name and mailing address of the ISA/US
Commissioner of Patents and Trademarks
Box PCT

Authorized officer

WILLIE MORRIS WORTH

INTERNATIONAL SEARCH REPORT

International application No.
PCT/US96/12499

C (Continuation). DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	US 4,489,601 A (RAO ET AL.) 25 December 1984, see the entire document.	1-12
A	US 4,621,264 A (YASHIRO ET AL.) 04 November 1986, see the entire document.	1-12
A	US 5,249,463 A (WILLSON ET AL.) 05 October 1993, see the entire document.	1-12
A	US 5,278,567 A (NOURRCIER) 11 January 1994, see the entire document.	1-12
A	US 5,345,471 A (MCEWAN) 06 September 1994, see the entire document.	1-12
A	US 5,384,541 A (CHU ET AL.) 24 January 1995, see the entire document.	1-12
A	US 5,517,198 A (MCEWAN) 14 May 1996, see the entire document.	1-12
A	US 5,563,605 A (MCEWAN) 08 October 1996, see the entire document.	1-12